





SN74LV594A

SCLS413K - APRIL 1998 - REVISED DECEMBER 2022

SN74LV594A 8-Bit Shift Registers With Output Registers

1 Features

- V_{CC} operation of 2 V to 5.5 V
- Maximum tpd of 6.5 ns at 5 V
- Typical V_{OLP} (output ground bounce) <0.8 V at V_{CC} = 3.3 V, TA = 25°C
- Support mixed-mode voltage operation on all ports
- 8-bit serial-in, parallel-out shift registers with
- Independent direct overriding clears on shift and storage registers
- Independent clocks for shift and storage registers
- Latch-up performance exceeds 100 mA per JESD

2 Applications

- ECG electrocardiograms
- Storage servers
- EPOS, ECR, and cash drawers
- Servers and high-performance computing

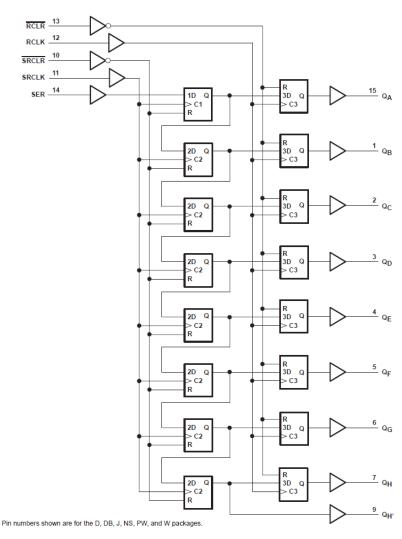
3 Description

The SN74LV594A devices are 8-bit shift registers designed for 2 V to 5.5 V V_{CC} operation.

Package Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)			
	DB (SSOP, 16)	6.20 mm × 5.30 mm			
SN74LV594A	D (SOIC, 16)	9.90 mm × 3.91 mm			
3N/4LV394A	PW (TSSOP, 16)	5.00 mm × 4.40 mm			
	BQB (WQFN, 16)	3.60 mm × 2.60 mm			

For all available packages, see the orderable addendum at the end of the data sheet.



Logic Diagram (Positive Logic)



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision J (February 2015) to Revision K (December 2022)

Page

 Added BQB package information to Pin Configuration and Functions and Thermal Information. Updated the format of tables, figures, and cross-references throughout the document.

Changes from Revision I (April 2005) to Revision J (February 2015)

Page

Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device
Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout
section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information
section

Submit Document Feedback

5 Pin Configuration and Functions

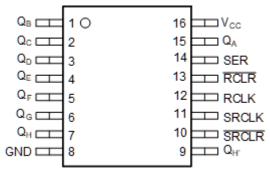


Figure 5-1. D, DB, or PW Package 16-Pin SOIC, SSOP, or TSSOP Top View

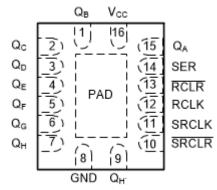


Figure 5-2. BQB Package 16-Pin WQFN Top View

Table 5-1. Pin Functions

	PIN	TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.	ITPE	DESCRIPTION
Q _B	1	0	Output B
Q _C	2	0	Output C
Q _D	3	0	Output D
Q _E	4	0	Output E
Q _F	5	0	Output F
Q_G	6	0	Output G
Q _H	7	0	Output H
GND	8	G	Ground pin
Q _H '	9	0	Q _H inverted
SRCLR	10	1	Serial clear
SRCLK	11	1	Serial clock
RCLK	12	1	Storage clock
RCLR	13	I	Storage clear
SER	14	1	Serial input
Q _A	15	0	Output A
Vcc	16	Р	Power pin
PAD	_	_	Thermal Pad

⁽¹⁾ I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power.

⁽²⁾ BQB Package Only



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

			MIN	MAX	UNIT		
V _{CC}	Supply voltage		-0.5	7	V		
VI	Input voltage ⁽²⁾	-0.5	7	V			
Vo	Voltage range applied to any output in the high-imp	-0.5	7	V			
Vo	Output voltage ^{(2) (3)}	Output voltage ^{(2) (3)}					
I _{IK}	Input clamp current	V _I < 0	-20		mA		
I _{OK}	Output clamp current	V _O < 0	-50		mA		
Io	Continuous output current	$V_O = 0$ to V_{CC}	-25	25	mA		
T _{stg}	Storage temperature	·	-65	150	°C		

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- 2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
- (3) The value is limited to 5.5 V maximum.

6.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

Product Folder Links: SN74LV594A



6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			SN74LV5	94A	LINUT	
			MIN	MAX	UNIT	
V _{CC}	Supply voltage		2	5.5	V	
		V _{CC} = 2 V	1.5			
.,	High-level input voltage	V _{CC} = 2.3 V to 2.7 V	V _{CC} × 0.7		V	
V_{IH}	i ligit-level lilput voltage	V _{CC} = 3 V to 3.6 V	V _{CC} × 0.7		V	
		V _{CC} = 4.5 V to 5.5 V	V _{CC} × 0.7			
		V _{CC} = 2 V		0.5		
\	Lew level input valtage	V _{CC} = 2.3 V to 2.7 V		V _{CC} × 0.3	V	
V_{IL}	Low-level input voltage	V _{CC} = 3 V to 3.6 V		V _{CC} × 0.3	V	
		V _{CC} = 4.5 V to 5.5 V		V _{CC} × 0.3		
VI	Input voltage		0	5.5	V	
Vo	Output voltage		0	V _{CC}	V	
		V _{CC} = 2 V		-50	μA	
	High level in mot assument	V _{CC} = 2.3 V to 2.7 V		-2		
I _{OH}	High-level input current	V _{CC} = 3 V to 3.6 V		6	mA	
		V _{CC} = 4.5 V to 5.5 V	V _{CC} = 4.5 V to 5.5 V V _{CC} = 2 V V _{CC} = 2.3 V to 2.7 V V _{CC} = 3 V to 3.6 V V _{CC} = 4.5 V to 5.5 V 0 0 0 V _{CC} = 2 V V _{CC} = 2.3 V to 2.7 V V _{CC} = 3 V to 3.6 V V _{CC} = 3 V to 5.5 V V _{CC} = 3 V to 5.5 V V _{CC} = 4.5 V to 5.5 V V _{CC} = 4.5 V to 5.5 V V _{CC} = 4.5 V to 5.5 V V _{CC} = 2.3 V to 2.7 V V _{CC} = 3 V to 3.6 V V _{CC} = 3 V to 3.6 V V _{CC} = 3 V to 5.5 V V _{CC} = 3 V to 5.5 V	-12		
		V _{CC} = 2 V		50	μA	
	Low lovel output ourrent	V _{CC} = 2.3 V to 2.7 V		2		
I _{OL}	Low-level output current	V _{CC} = 3 V to 3.6 V		6	mA	
		V _{CC} = 4.5 V to 5.5 V		12		
		V _{CC} = 2.3 V to 2.7 V		200		
Δt/Δν	Input transition rise or fall rate	V _{CC} = 3 V to 3.6 V		100	ns/V	
		V _{CC} = 4.5 V to 5.5 V		20		
T _A	Operating free-air temperature		-40	125	°C	

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report *Implications of Slow or Floating CMOS Inputs*, SCBA004.

6.4 Thermal Information

		SN74LV594A							
	THERMAL METRIC ⁽¹⁾	D (SOIC)	DB (SSOP)	PW (TSSOP)	UNIT				
		16 PINS	16 PINS	16 PINS	16 PINS				
$R_{\theta JA}$	Junction-to-ambient thermal resistance	85.9	80.2	97.8	106.1				
R _{0JC(top)}	Junction-to-case (top) thermal resistance	82.4	40.3	48.1	40.8				
$R_{\theta JB}$	Junction-to-board thermal resistance	55.6	38	48.5	51.1	°C/W			
ΨЈТ	Junction-to-top characterization parameter	9.4	9	10	3.8	C/VV			
ΨЈВ	Junction-to-board characterization parameter	55.6	37.7	47.9	50.6				
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	33.3	N/A	N/A	N/A				

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.



6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	vcc	SN54	LV594A			LV594A TO 85°C	;		LV594A TO 125°C		UNIT
	CONDITIONS		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
	I _{OH} = -50 μA	2 V to 5.5 V	V _{CC} - 0.1			V _{CC} - 0.1			V _{CC} - 0.1			
V _{OH}	I _{OH} = -2 μA	2.3 V	2			2			2			V
VOH	I _{OH} = -6 μA	3 V	2.48			2.48			2.48			V
	I _{OH} = -12 μA	4.5 V	3.8			3.8			3.8			
	I _{OH} = -50 μA	2 V to 5.5 V			0.1			0.1			0.1	
	I _{OH} = -2 μA	2.3 V			0.4			0.4			0.4	V
V _{OL}	I _{OH} = -6 μA	3 V			0.44			0.44			0.44	V
	I _{OH} = -12 μA	4.5 V			0.55			0.55			0.55	
I _I	V _I = 5.5 V or GND	0 to 5.5 V			±1			±1			±1	μΑ
Icc	$V_I = V_{CC}$ of GND, $I_O = 0$	5.5 V			20			20			20	μΑ
I _{off}	$V_1 \text{ or } V_0 = 0 \text{ to } 5.5 \text{ V}$	0		,	5			5			5	μA
C _i	V _I = V _{CC} or GND	3.3 V		3.5			3.5					pF

6.6 Switching Characteristics: V_{CC} = 2.5 V ± 0.2 V

over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted). See Figure 6-1.

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°C			SN74LV594A -40°C TO 85°C		SN74LV594A -40°C TO 125°C		UNIT
	(INFUT)	(001701)		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
£			C _L = 15 pF	65 ⁽¹⁾	80 ⁽¹⁾		45		35		MHz
f _{max}			C _L = 50 pF	60	70		40		30		IVITZ
t _{PLH}		0 0			6.4 ⁽¹⁾	10.6 ⁽¹⁾	1	11.1	1	12.5	
t _{PHL}	SRCLK	$Q_A - Q_H$			6.3 ⁽¹⁾	10.4(1)	1	11.1	1	12.5	
t _{PLH}	1	0	C _L = 15 pF		7.4 ⁽¹⁾	12.1 ⁽¹⁾	1	12.8	1	15	ns
t _{PHL}		Q _H	CL = 15 pr		7.2 ⁽¹⁾	11.6 ⁽¹⁾	1	12.8	1	15	115
	RCLK Q _A – Q _H		7.9 ⁽¹⁾	12.7 ⁽¹⁾	1	13.6	1	15.5			
t _{PHL}		Q _H '			7.4 ⁽¹⁾	11.9 ⁽¹⁾	1	13.1	1	15.5	
t _{PLH}		0 0			9.5	14.1	1	14.6	1	17	
t _{PHL}	SRCLR	$Q_A - Q_H$			10.8	15.5	1	17.2	1	19.5	
t _{PLH}	1	0	0 - 50 -5		10.6	15.7	1	16.5	1	18.5	
t _{PHL}		Q _H	C _L = 50 pF		11.3	16.1	1	18.6	1	20.5	ns
	RCLR	Q _A – Q _H			12.1	17.4	1	19	1	21	
t _{PHL}		Q _H '			11.6	16.5	1	18.6	1	20.6	1

(1) On products compliant to MIL-PRF-38535, this parameter is not production tested.

6.7 Switching Characteristics: V_{CC} = 3.3 V ± 0.3 V

over recommended operating free-air temperature range, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ (unless otherwise noted). See Figure 6-1.

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	TA	= 25°C		SN74LV5 -40°C TO		SN74LV59 -40°C TO 1		UNIT			
	(INPUT)	(001701)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX				
f			C _L = 15 pF	80 ⁽¹⁾	120 ⁽¹⁾		70		60		MHz			
f _{max}			C _L = 50 pF	55	105		50		40		IVI⊓∠			
t _{PLH}		Q _A – Q _H			4.6 ⁽¹⁾	8(1)	1	8.5	1	10.5				
t _{PHL}	SRCLK				4.9 ⁽¹⁾	8.2 ⁽¹⁾	1	8.8	1	10.5				
t _{PLH}		0	C _L = 15 pF		5.4 ⁽¹⁾	9.1 ⁽¹⁾	1	9.7	1	11.5	ns			
t _{PHL}		Q _H	CL = 15 pr		5.5 ⁽¹⁾	9.2 ⁽¹⁾	1	9.9	1	11.6	115			
+	RCLK	Q _A – Q _H			6 ⁽¹⁾	9.8 <mark>(1)</mark>	1	10.6	1	12.1				
t _{PHL}		Q _H '			5.6 ⁽¹⁾	9.2 ⁽¹⁾	1	10	1	12				
t _{PLH}		0 0	0 0	0 0	0. 0					1	11.1	1	12.5	
t _{PHL}	SRCLR	$Q_A - Q_H$					1	13.1	1	15				
t _{PLH}		0	C = 50 pE				1	12.4	1	14	no			
t _{PHL}		Q _H '	C _L = 50 pF				1	13.9	1	15.5	ns			
t _{PHL}	RCLR	$Q_A - Q_H$					1	14.4	1	16.1				
		Q _H '					1	14	1	16				

⁽¹⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested.

6.8 Switching Characteristics: $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted). See Figure 6-1.

PARAMETER	FROM	TO	LOAD	TA	= 25°C		SN74LV59 -40°C TO	-	SN74LV5 -40°C TO 1	-	UNIT			
	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX				
£			C _L = 15 pF	135 ⁽¹⁾	170 ⁽¹⁾		115		105		MHz			
f _{max}			C _L = 50 pF	120	140		95		85		IVITZ			
t _{PLH}		0 0			3.3(1)	6.2 ⁽¹⁾	1	6.5	1	8				
t _{PHL}	SRCLK	$Q_A - Q_H$			3.7 ⁽¹⁾	6.5 ⁽¹⁾	1	6.9	1	8.5				
t _{PLH}			C _L = 15 pF		3.7 ⁽¹⁾	6.8 ⁽¹⁾	1	7.2	1	8.5	no			
t _{PHL}		Q _H	C _L = 15 pr		4.1 ⁽¹⁾	7.2 ⁽¹⁾	1	7.6	1	9	ns			
	RCLK	$Q_A - Q_H$			4.5 ⁽¹⁾	7.6 ⁽¹⁾	1	8.2	1	9.5				
t _{PHL}		Q _H			4.1 ⁽¹⁾	7.1 ⁽¹⁾	1	7.6	1	9				
t _{PLH}		0 0			4.9	7.8	1	8.3	1	9.6				
t _{PHL}	SRCLR	$Q_A - Q_H$	$Q_A - Q_H$	$Q_A - Q_H$	$Q_A - Q_H$			5.8	8.9	1	9.7	1	11	
t _{PLH}		0	0 - 50 - 5		5.5	8.6	1	9.1	1	10.5				
t _{PHL}		Q _H '	C _L = 50 pF		6	9.2	1	10.1	1	11.5	ns			
t _{PHL}	RCLR	$Q_A - Q_H$			6.6	10	1	10.7	1	12				
		Q _H			6	9.2	1	10.1	1	11.5				

⁽¹⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested.

6.9 Timing Requirements: $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$

over recommended operating free-air temperature range, V_{CC} = 2.5 V ± 0.2 V. See Figure 6-1.

			T _A = 25	°C	SN74LV594A -40°C TO 85°C		SN74LV594A -40°C TO 125°C		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
	Pulse duration	RCLK or SRCLK high or low	7		7.5		8.5		
t _w	Fuise duration	RCKR or SCRCLR low	6		6.5		7.5		ns
		SER before SRCLK↑	5.5		5.5		6		
		SRCLK↑ before RCLK↑	8		9		10		
t _{su}	Setup time	SCRCLR low before RCLK↑(1)	8.5		9.5		10.5		ns
		SRCLR high (inactive) before SRCLK↑	6		6.8		7.5		
		RCLK high (inactive) before RCLK↑	6.7		7.6		8.5		
t _h	Hold time	SER after SRCLK↑	1.5		1.5		2		ns

⁽¹⁾ This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

6.10 Timing Requirements: V_{CC} = 3.3 V ± 0.3 V

over recommended operating free-air temperature range, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$. See Figure 6-1.

			T _A = 25	°C	SN74LV59 -40°C TO 8		SN74LV594 -40°C TO 12	UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX	
	w Pulse duration	RCLK or SRCLK high or low	5.5		5.5		6.5		no
τ _w		RCKR or SCRCLR low	5		5		6		ns
		SER before SRCLK↑	3.5		3.5		4		
		SRCLK↑ before RCLK↑	8		8.5		9.5		
t _{su}	Setup time	SCRCLR low before RCLK↑(1)	8		9		10		ns
		SRCLR high (inactive) before SRCLK↑	4.2		4.8		5.5		
		RCLK high (inactive) before RCLK↑	4.6		5.3		6		
t _h	Hold time	SER after SRCLK↑	1.5		1.5		2		ns

⁽¹⁾ This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

Product Folder Links: SN74LV594A

6.11 Timing Requirements: $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V. See Figure 6-1.

			T _A = 25	°C	SN74LV59 -40°C TO		SN74LV594 -40°C TO 12	UNIT			
			MIN	MAX	MIN	MAX	MIN	MAX			
	Pulse duration	RCLK or SRCLK high or low	5		5		6		no		
t _w	Pulse duration	RCKR or SCRCLR low	5.2		5.2		6.2		ns		
		SER before SRCLK↑	3		3		3.5				
	Setup time	SRCLK↑ before RCLK↑	5		5		6				
t _{su}		SCRCLR low before RCLK↑(1)	5		5		5.5		ns		
		S	SRCLR high (inactive) before SRCLK↑	2.9		3.3		4			
		RCLK high (inactive) before RCLK↑	3.2		3.7		4.5				
t _h	Hold time	SER after SRCLK↑	2		2		2.5		ns		

⁽¹⁾ This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

6.12 Noise Characteristics

over operating free-air temperature range (unless otherwise noted), V_{CC} = 3.3 V, C_L = 50 pF, T_A = 25°C

	PARAMETER	MIN	TYP	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.5	0.8	V
V _{OL(V)}	Quiet output, minimum dynamic V _{OL}		-0.1	-0.8	V
V _{OH(V)}	Quiet output, minimum dynamic V _{OH}		2.8		V
V _{IH(V)}	High-level dynamic input voltage	2.31			V
V _{IL(V)}	Low-level dynamic input voltage			0.99	V

6.13 Operating Characteristics

 $T_A = 25^{\circ}C$

· A = -					
	PARAMETER	TEST CONDITIONS	V _{CC}	TYP	UNIT
<u></u>	Dower discingtion conscitutes	f = 10 MHz	3.3 V	93	nE
Cpd	Power dissipation capacitance	I - IU WITZ	5 V	112	pF



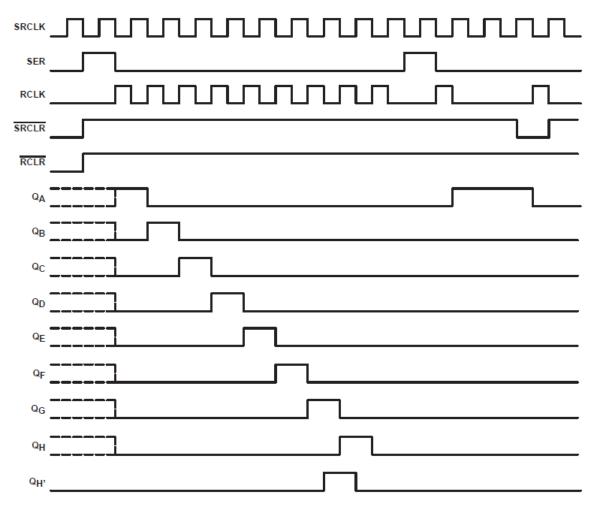
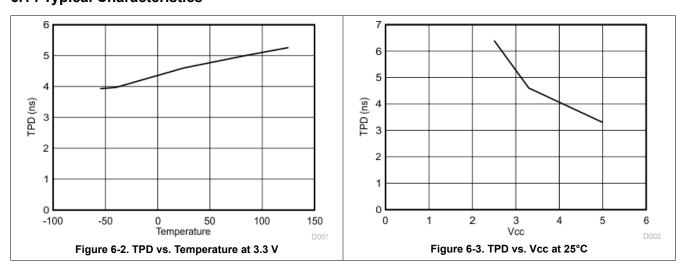
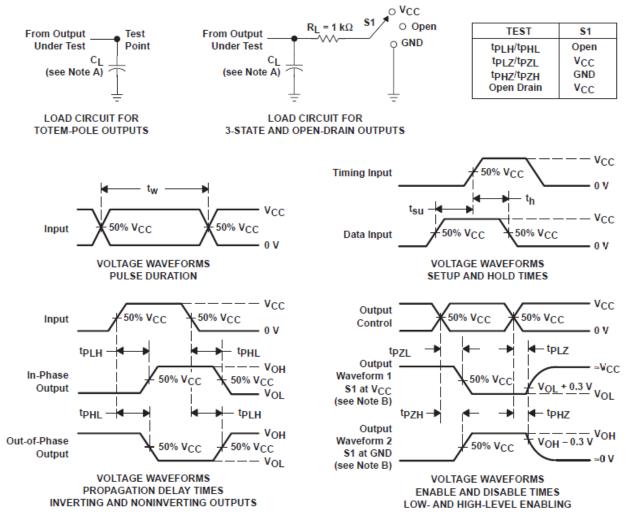


Figure 6-1. Timing Diagram

6.14 Typical Characteristics



7 Parameter Measurement Information



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , $t_f \leq$ 3 ns. $t_f \leq$ 3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- tPHL and tPLH are the same as tpd.
- H. All parameters and waveforms are not applicable to all devices.

Figure 7-1. Load Circuit and Voltage Waveforms



8 Detailed Description

8.1 Overview

The SN74LV594A devices are 8-bit shift registers designed for 2 V to 5.5 V V_{CC} operation.

These devices contain an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. Separate clocks (RCLK, SRCLK) and direct overriding clear (\overline{RCLR} , \overline{SRCLR}) inputs are provided on the shift and storage registers. A serial output ($Q_{H'}$) is provided for cascading purposes. The shift-register (SRCLK) and storage-register (RCLK) clocks are positive-edge triggered. If the clocks are tied together, the shift register always is one clock pulse ahead of the storage register.

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Product Folder Links: SN74LV594A



8.2 Functional Block Diagram

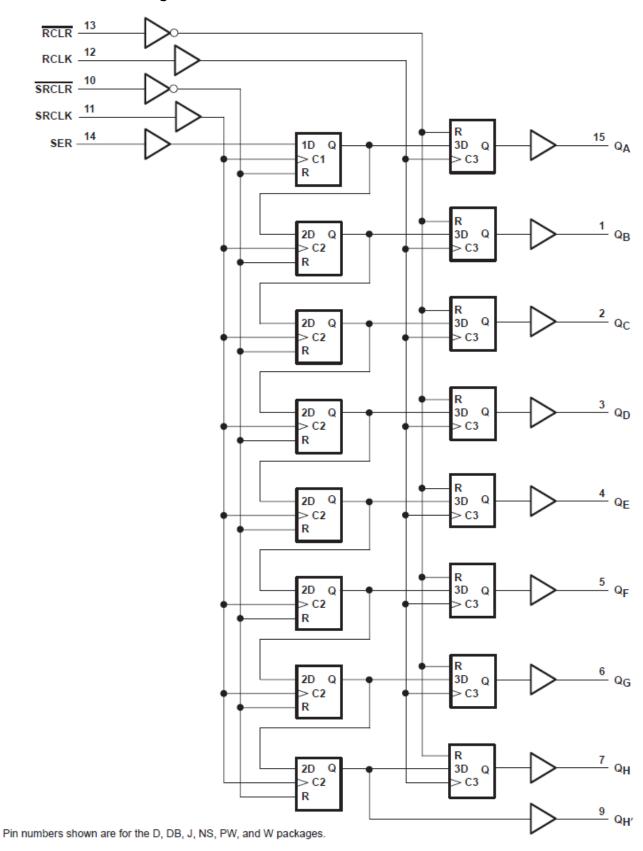


Figure 8-1. Logic Diagram (Positive Logic)

Product Folder Links: SN74LV594A



8.3 Feature Description

The device's wide operating range allows it to be used in a variety of systems that use different logic levels. The low propagation delay allows fast switching and higher speeds of operation. In addition, the low ground bounce stabilizes the performance of non-switching outputs while another output is switching.

8.4 Device Functional Modes

Table 8-1. Function Table

	Table 6-1.1 unction Table												
		INPUTS	FUNCTION										
SER	SRCLK	SRCLR	RCLK	RCLR	FUNCTION								
Х	X	L	X	Х	Shift register is cleared.								
L	1	Н	Х	Х	First stage of shift register goes low. Other stages store the data of previous stage, repectively.								
Н	1	Н	Х	X	First stage of shift register goes high. Other stages store the data of previous stage, respectively.								
L	1	Н	X	Х	Shift register state is not changed.								
Х	X	X	X	L	Storage register is cleared.								
Х	Х	Х	1	Н	Shift register data is stored in the storage register.								
Х	X	Х	1	Н	Storage register state is not changed.								

Product Folder Links: SN74LV594A

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9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The SN74LV594A is a low drive CMOS device that can be used for a multitude of bus interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs.

9.2 Typical Application

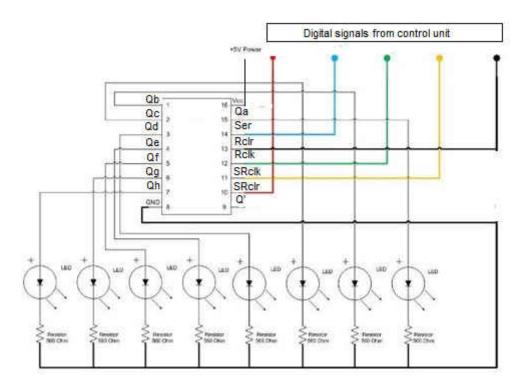


Figure 9-1. Typical Application Schematic

9.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads so consider routing and load conditions to prevent ringing.

9.2.2 Detailed Design Procedure

- · Recommended input conditions:
 - Rise time and fall time specs. See (Δt/ΔV) in Section 6.3.
 - Specified high and low levels. See (V_{IH} and V_{IL}) in Section 6.3.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V_{CC}.
- · Recommended output conditions:
 - Load currents should not exceed 25 mA per output and 50 mA total for the part.
 - Outputs should not be pulled above V_{CC}.

9.2.3 Application Curves

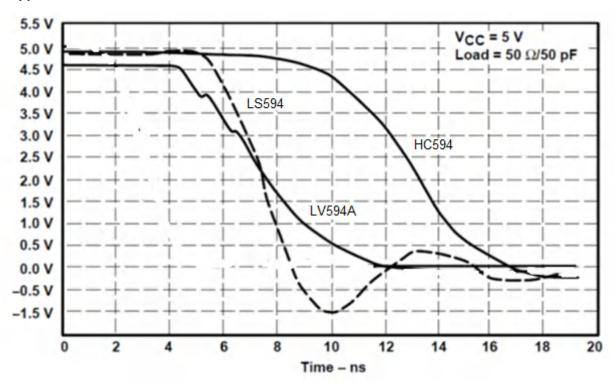


Figure 9-2. Switching Characteristics Comparison

9.3 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the Section 6.3. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends a 0.1- μ F capacitor and if there are multiple V_{CC} terminals then TI recommends a 0.01- μ F or 0.022- μ F capacitor for each power terminal. Multiple bypass capacitors can be paralleled to reject different frequencies of noise. Frequencies of 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close as possible to the power terminal for best results.

9.4 Layout

9.4.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only three of the four buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified below are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they

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will be tied to GND or V_{CC} whichever make more sense or is more convenient. Floating outputs is generally acceptable, unless the part is a transceiver. If the transceiver has an output enable pin it will disable the outputs section of the part when asserted. This will not disable the input section of the I.O's so they also cannot float when disabled.

9.4.2 Layout Example



Figure 9-3. Layout Example



10 Device and Documentation Support

10.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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10.3 Trademarks

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10.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: SN74LV594A

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	Dall an ataulat		MSL rating/ Peak reflow	Op temp (°C)	Part marking
	(1)	(2)			(3)				(6)
SN74LV594ABQBR	Active	Production	WQFN (BQB) 16	3000 LARGE T&R	Yes	SELECTIVE AG (TOP SIDE)	(5) Level-1-260C-UNLIM	-40 to 125	LV594A
SN74LV594ABQBR.A	Active	Production	WQFN (BQB) 16	3000 LARGE T&R	Yes	SELECTIVE AG (TOP SIDE)	Level-1-260C-UNLIM	-40 to 125	LV594A
SN74LV594AD	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-40 to 125	LV594A
SN74LV594ADBR	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV594A
SN74LV594ADBR.A	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV594A
SN74LV594ADR	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV594A
SN74LV594ADR.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV594A
SN74LV594APWR	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	LV594A
SN74LV594APWR.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV594A
SN74LV594APWRG4	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV594A
SN74LV594APWRG4.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV594A

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

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Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

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OTHER QUALIFIED VERSIONS OF SN74LV594A:

Automotive: SN74LV594A-Q1

NOTE: Qualified Version Definitions:

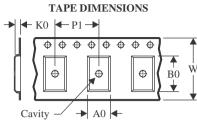
Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

www.ti.com 24-Jul-2025

TAPE AND REEL INFORMATION





	-
A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

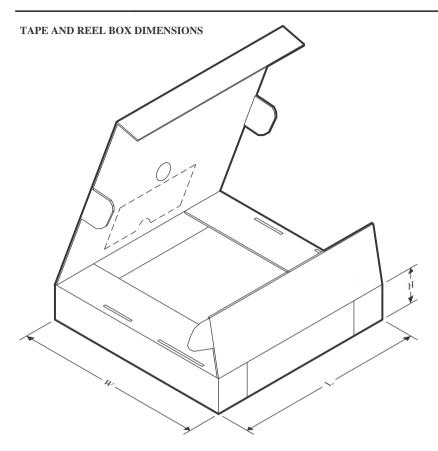


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV594ABQBR	WQFN	BQB	16	3000	180.0	12.4	2.8	3.8	1.2	4.0	12.0	Q1
SN74LV594ADBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74LV594ADR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74LV594APWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV594APWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV594APWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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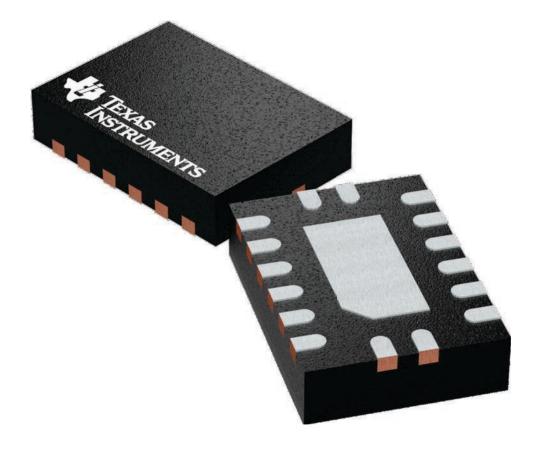
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV594ABQBR	WQFN	BQB	16	3000	210.0	185.0	35.0
SN74LV594ADBR	SSOP	DB	16	2000	353.0	353.0	32.0
SN74LV594ADR	SOIC	D	16	2500	353.0	353.0	32.0
SN74LV594APWR	TSSOP	PW	16	2000	356.0	356.0	35.0
SN74LV594APWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0
SN74LV594APWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0

2.5 x 3.5, 0.5 mm pitch

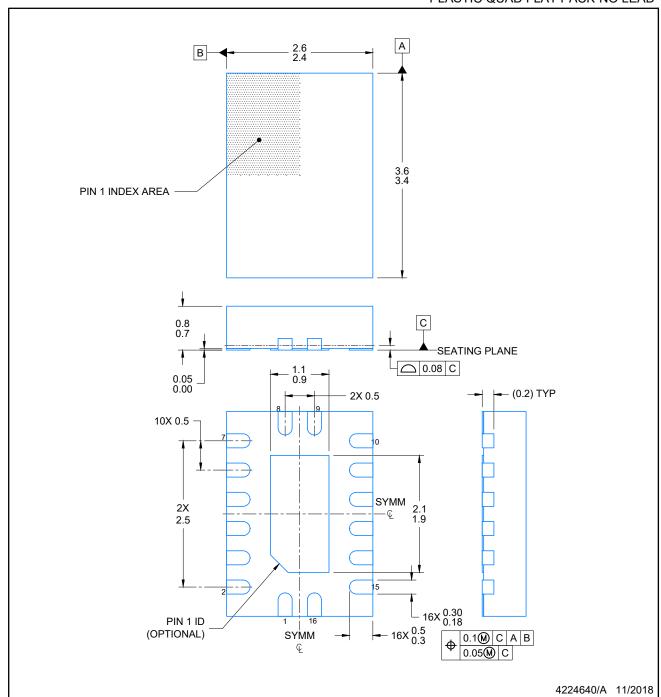
PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



INSTRUMENTS www.ti.com

PLASTIC QUAD FLAT PACK-NO LEAD

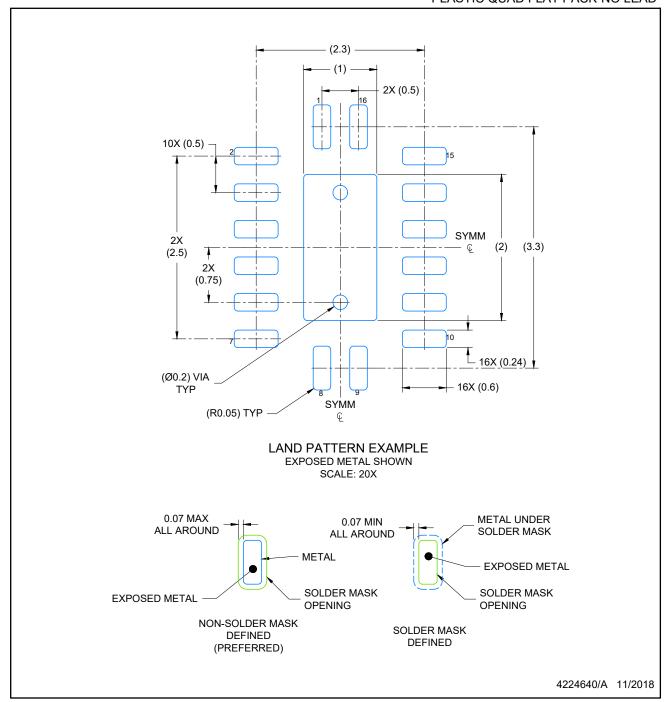


NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



PLASTIC QUAD FLAT PACK-NO LEAD

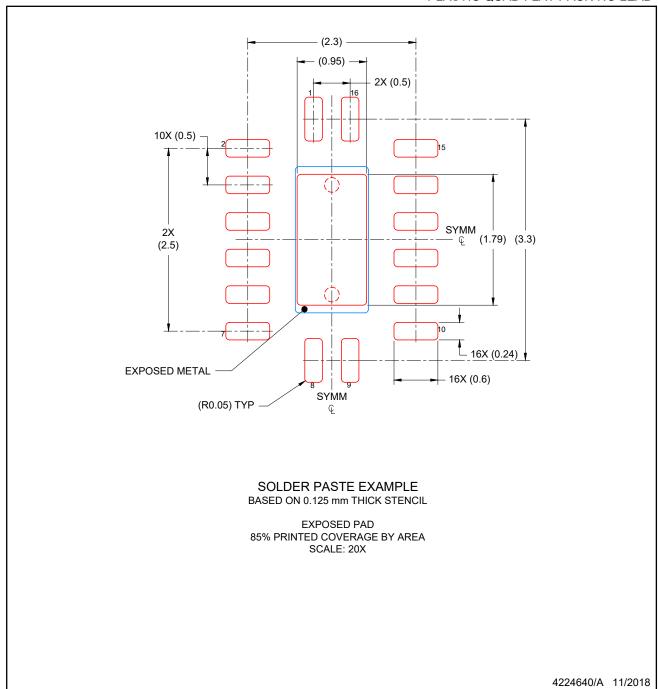


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLAT PACK-NO LEAD

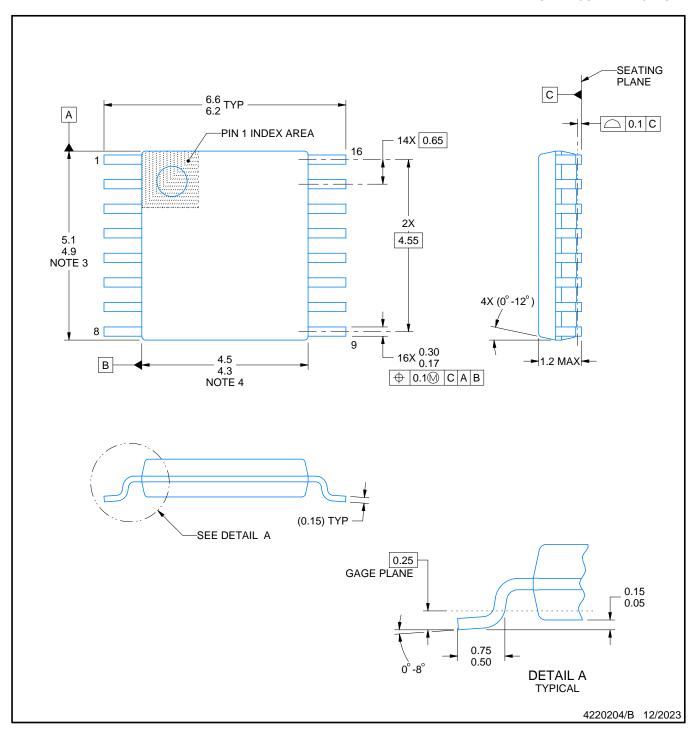


NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.







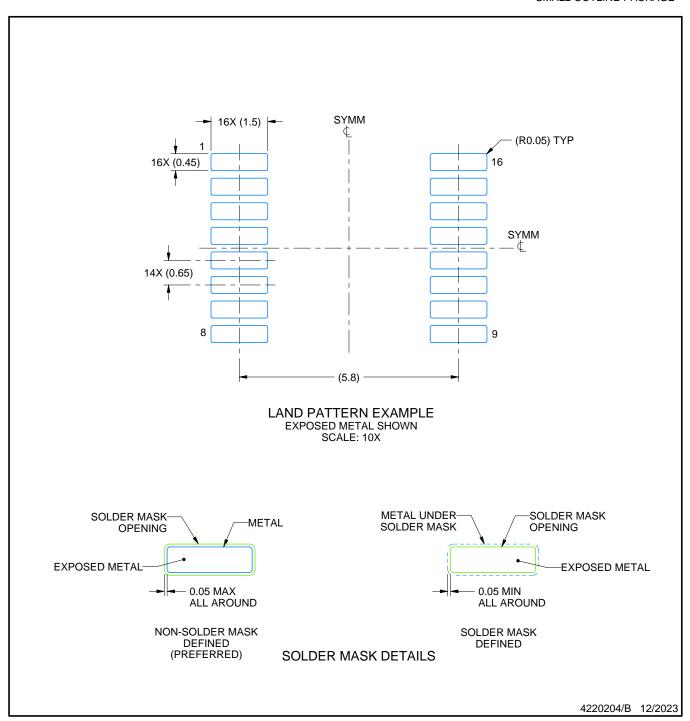
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.

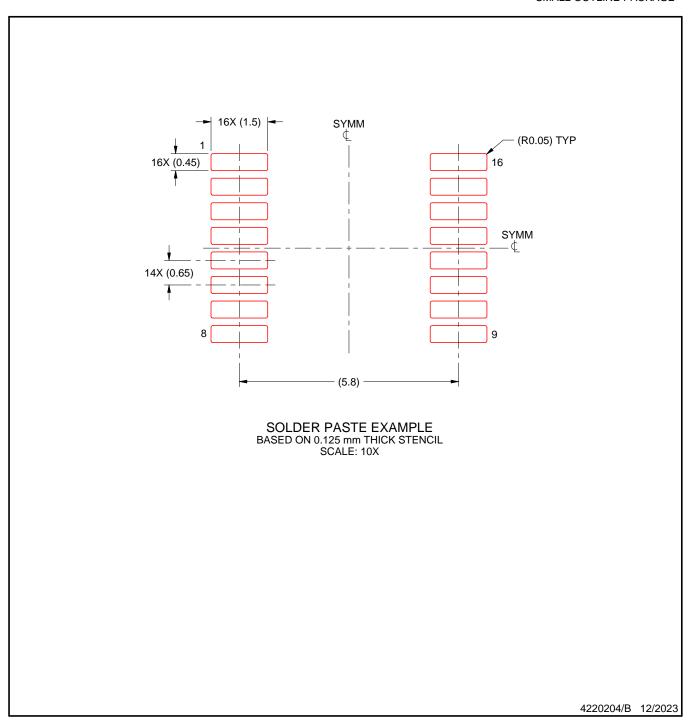




NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





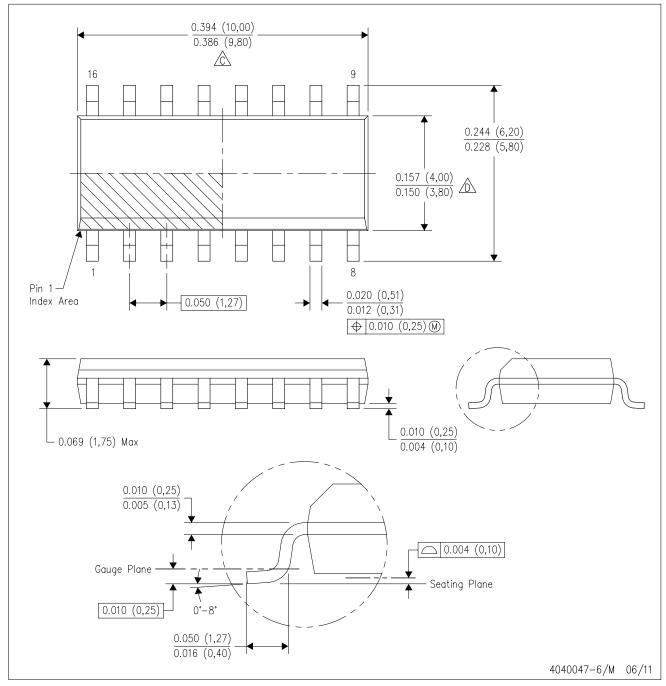
NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



D (R-PDS0-G16)

PLASTIC SMALL OUTLINE

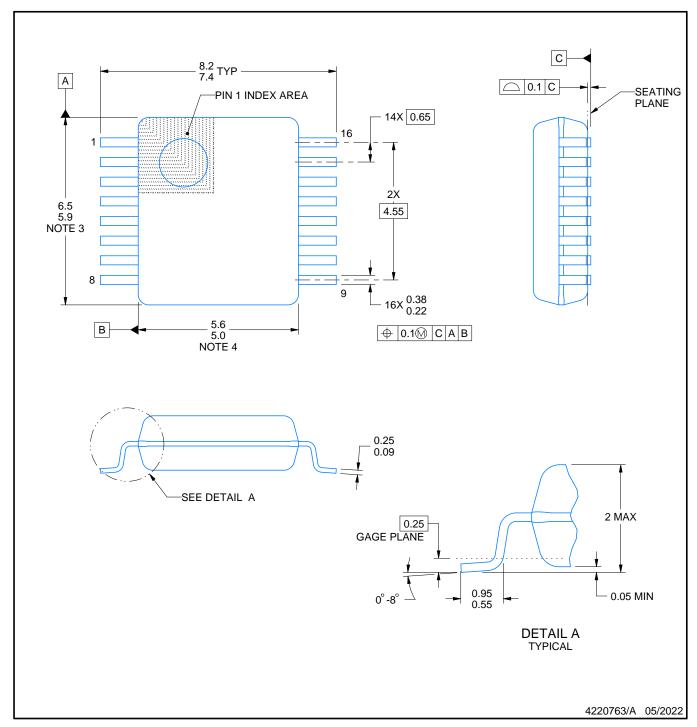


NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.







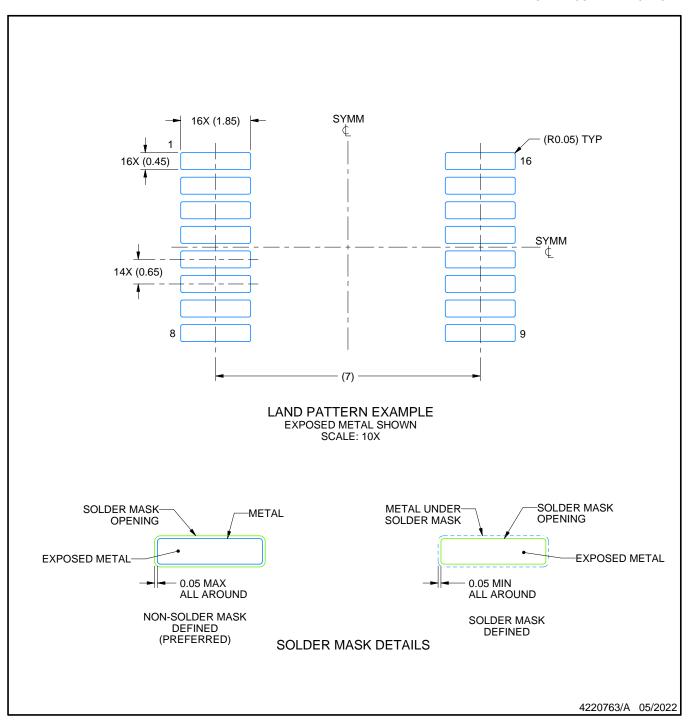
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-150.

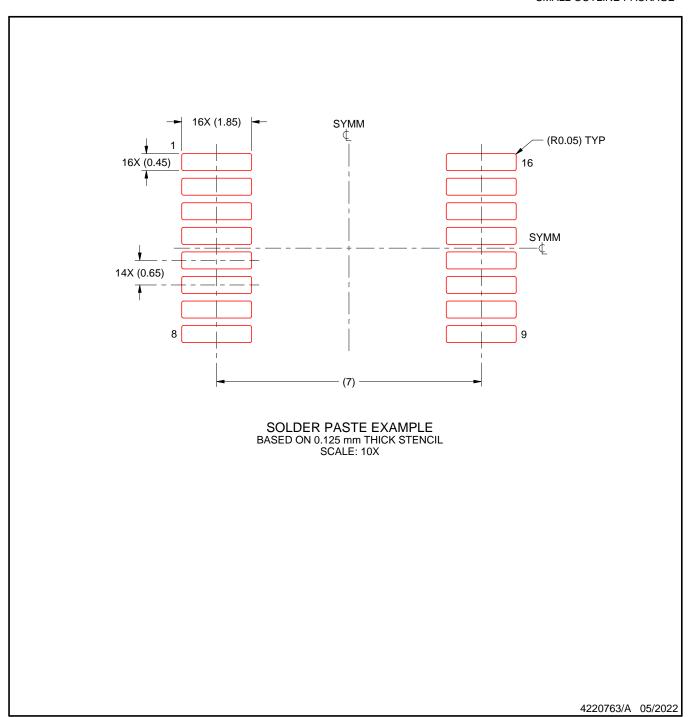




NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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